

MOSFET

600V CoolMOS™ SJ S7 Power Device

CoolMOS™ S7T enables the best price performance for low-frequency switching applications. The embedded temperature sensor increases junction temperature sensing accuracy and robustness while keeping an easy and seamless implementation. CoolMOS™ S7T is optimized for "static switching" and high current applications. The new temperature sensor enhances S7 features, allowing the best possible utilization of the power transistor.

Features

- Optimized price performance in low-frequency switching applications
- · High pulse current capability
- Seamless diagnostics at the lowest system cost
- Temperature sense feature for protection and optimized thermal device utilization cost

Benefits

- Reduction of external sensing elements, hence a more compact design compared to electromechanical devices
- Increased system performance
- Minimized conduction losses (eliminate/reduce heat sink)
- Increased system performance
- More compact and more straightforward design
- Lower BOM or/and TCO over a prolonged lifetime
- · More reliability and longer system lifetime

Potential applications

- Solid state relays and circuit breakers (PLC, Energy storage)
- Line rectification in high power/performance applications (Computing, Telecom, UPS and Solar)

Product validation

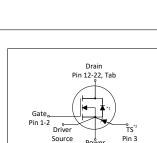
Fully qualified according to JEDEC for Industrial Applications

Please note: The source and sense source pins are not exchangeable. Their exchange might lead to malfunction. For paralleling 4pin MOSFET devices the placement of the gate resistor is generally recommended to be on the Driver Source instead of the Gate.



Parameter	Value	Unit
R _{DS(on),max}	22	mΩ
Q _{g,typ}	150	nC
V _{SD}	0.82	V
Pulsed I _{SD} , I _{DS}	371	A
ESD class (HBM)	2	JEDEC JS-001

Type / Ordering Code	Package	Marking	Related Links
IPDQ60T022S7	PG-HDSOP-22	60I022S7	see Appendix A



Source

PG-HDSOP-22



Pin 4





600V CoolMOS™ SJ S7 Power Device IPDQ60T022S7



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1 Maximum ratings at $T_j = 25$ °C, unless otherwise specified

Table 2 **Maximum MOSFET ratings**

Davamatar	Cumb al	Values			11!4	Nata / Tank Oam dition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain current rating ¹⁾	I _D	-	-	90 24	А	T _C =25°C T _C =140°C
Pulsed drain current ²⁾	I _{D,pulse}	-	-	371	Α	T _C =25°C
Avalanche energy, single pulse	E AS	-	-	286	mJ	I_D =3.7A; V_{DD} =50V; see table 11
Avalanche current, single pulse	I _{AS}	-	-	3.7	Α	-
MOSFET dv/dt ruggedness ³⁾	dv/dt	-	-	20	V/ns	V _{DS} = 0V to 300V
Gate source voltage (static)	V _{GS}	-20	-	20	V	static
Gate source voltage (dynamic)	V _{GS}	-30	-	30	V	AC (f>1 Hz)
Power dissipation	P _{tot}	-	-	416	W	T _C =25°C
Storage temperature	$T_{ m stg}$	-55	-	150	°C	-
Operating junction temperature ¹⁾	T _j	-55	-	150	°C	-
Extended operating junction temperature	T _j	150	-	175	°C	≤50 h in the application lifetime
Mounting torque	-	-	-	n.a.	Ncm	-
Diode forward current rating	I _S	-	-	24	A	T _C =140°C Current is limited by T _{j max} = 150°C; Lower case temp does increase current capability
Diode pulse current ¹⁾	I _{S,pulse}	-	-	371	Α	T _C =25°C
Reverse diode dv/dt ⁴⁾	dv/dt	-	-	5	V/ns	$V_{\rm DS}$ =0 to 300V, $I_{\rm SD}$ <=23A, $T_{\rm j}$ =25°C see table 9
Maximum diode commutation speed	di _f /dt	-	-	800	A/μs	$V_{\rm DS}$ =0 to 300V, $I_{\rm SD}$ <=23A, $T_{\rm j}$ =25°C see table 9
Insulation withstand voltage	V _{ISO}	-	-	n.a.	V	-

 $^{^{1)}}$ Please consider the App Note: 600 V CoolMOSTM S7 with Temperature Sense for high delta T_J usage $^{2)}$ Pulse width t_p limited by $T_{j,\text{max}}$ $^{3)}$ The dv/dt has to be limited by appropriate gate resistor $^{4)}$ Identical low side and high side switch

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2 Thermal characteristics

 Table 3
 Thermal characteristics

Downwater	Cumbal	Values			11!4	Note (Total Constitution
Parameter Symbol	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Thermal resistance, junction - case	RthJC	-	-	0.3	°C/W	-
Thermal resistance, junction - ambient	R _{thJA}	-	-	62	°C/W	device on PCB, minimal footprint
Thermal resistance, junction - ambient for SMD version	AthJA	-	45	55	°C/W	Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70µm thickness) copper area. Tap exposed to air. PCB is vertical without air stream cooling.
Soldering temperature, reflow soldering allowed	T _{sold}	-	-	260	°C	reflow MSL1

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infineon

Electrical characteristics

at T_j=25°C, unless otherwise specified

Table 4 Static characteristics

For applications with applied blocking voltage >420V, it is required that the customer evaluates the impact of cosmic radiation effect in early design phase and contacts the Infineon sales office for the necessary technical support by Infineon

Parameter Symbol		Values				
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V _{(BR)DSS}	600	-	-	V	V_{GS} =0V, I_D =1mA
Gate threshold voltage	$V_{(GS)th}$	3.5	4.0	4.5	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=1.43{\rm mA}$
Zero gate voltage drain current	I _{DSS}	-	- 50	5	μΑ	V _{DS} =600V, V _{GS} =0V, T _j =25°C V _{DS} =600V, V _{GS} =0V, T _j =150°C
Gate-source leakage current	I_{GSS}	-	-	100	nA	V _{GS} =20V, V _{DS} =0V
Drain-source on-state resistance	R _{DS(on)}	-	0.02 0.046	0.022	Ω	V _{GS} =12V, I _D =23A, T _j =25°C V _{GS} =12V, I _D =23A, T _j =150°C
Gate resistance	R _G	-	0.8	-	Ω	f=1MHz, open drain

Table 5 **Dynamic characteristics**

Dovementor	matar Sumbal		Values			Note / Took Condition
Parameter S	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	Ciss	-	5640	-	pF	V _{GS} =0V, V _{DS} =300V, f=250kHz
Output capacitance	Coss	-	89	-	pF	V _{GS} =0V, V _{DS} =300V, f=250kHz
Effective output capacitance, energy related ¹⁾	C _{o(er)}	-	302	-	pF	V _{GS} =0V, V _{DS} =0 to 300V
Effective output capacitance, time related ²⁾	C _{o(tr)}	-	2677	-	pF	I_D =constant, V_{GS} =0V, V_{DS} =0 to 300V
Output charge	Qoss	-	803	-	nC	V _{GS} =0V, V _{DS} =0 to 300V
Turn-on delay time	$t_{\sf d(on)}$	-	30	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =23A, $R_{\rm G}$ =5.3 Ω ; see table 9
Rise time	t _r	-	6	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =23A, $R_{\rm G}$ =5.3 Ω ; see table 9
Turn-off delay time	$t_{ m d(off)}$	-	142	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =23A, $R_{\rm G}$ =5.3 Ω ; see table 9
Fall time	t _f	-	10	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =23A, $R_{\rm G}$ =5.3 Ω ; see table 9

Table 6 Gate charge characteristics

Downworten Symbol	Cumbal	Values				Note / Test Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q _{gs}	-	31	-	nC	$V_{\rm DD}$ =300V, $I_{\rm D}$ =23A, $V_{\rm GS}$ =0 to 12V
Gate to drain charge	Q_{gd}	-	49	-	nC	$V_{\rm DD}$ =300V, $I_{\rm D}$ =23A, $V_{\rm GS}$ =0 to 12V
Gate charge total	Qg	-	150	-	nC	$V_{\rm DD}$ =300V, $I_{\rm D}$ =23A, $V_{\rm GS}$ =0 to 12V
Gate plateau voltage	V _{plateau}	-	5.4	-	V	$V_{\rm DD}$ =300V, $I_{\rm D}$ =23A, $V_{\rm GS}$ =0 to 12V

 $^{^{1)}}$ $C_{\text{o(er)}}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 300V $^{2)}$ $C_{\text{o(tr)}}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 300V

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Table 7 Reverse diode characteristics

Parameter Syn	Cumbal	Values			11	Note / Took Condition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode forward voltage	V _{SD}	-	0.82	-	V	V _{GS} =0V, I _F =23A, T _j =25°C
Reverse recovery time	t _{rr}	-	410	-	ns	V_R =300V, I_F =23A, di_F/dt =100A/ μ s; see table 8
Reverse recovery charge	Q _{rr}	-	10	-	μC	V_R =300V, I_F =23A, di_F/dt =100A/ μ s; see table 8
Peak reverse recovery current	I _{rrm}	-	48	-	А	V_R =300V, I_F =23A, di_F/dt =100A/ μ s; see table 8

600V CoolMOS™ SJ S7 Power Device IPDQ60T022S7



4 Temperature Sensor parameters at T_j =25°C, unless otherwise specified

Table 8 **Maximum ratings**

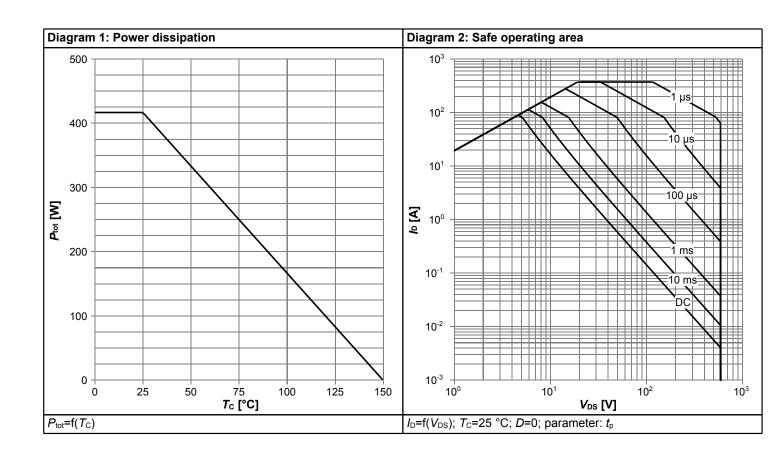
Parameter	Or made al		Values			Note / Took On well the m
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Repetitive Peak Reverse Voltage	V_{RRM}	-	-	15	V	<i>I</i> _R = 100 μA
Sensor forward current	I _F	-	-	5	mA	-
Repetitive peak forward current	I _{F_pulse}	-	-	25	mA	t _{pulse} = 1 ms, T _{period} = 10 ms
Non-repetitive peak forward current	I _{FSM}	- - -	- - -	1.5 0.2 0.1	A	T_C = 25°C, t_{pulse} = 1 μs T_C = 25°C, t_{pulse} = 1 ms T_C = 25°C, t_{pulse} = 1 s
Junction Temperature	T _j	-	-	185	°C	t < 50h, Sensor only

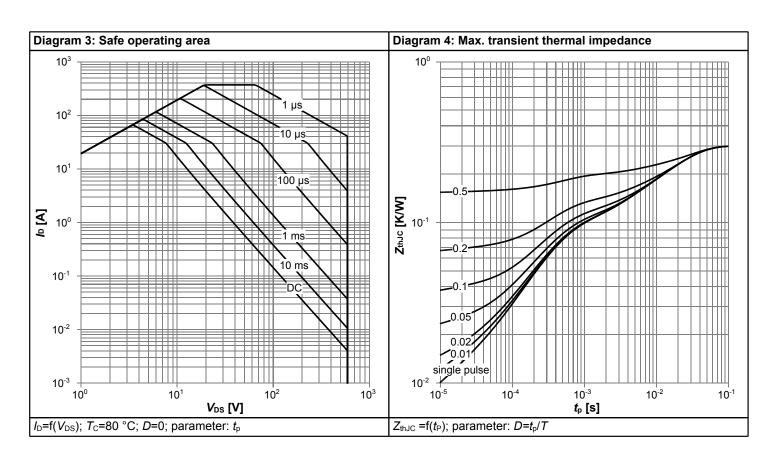
Electrical characteristics Table 9

Parameter	Symbol	Values			Unit	Note / Test Condition
Parameter Symbol	Min.	Тур.	Max.	Ullit	Note / Test Condition	
Sensor forward voltage ¹⁾	V _{F_25}	1.5601 - - 2.0665	1.6019 1.8103 1.9806 2.0966	-	V	$T_{j} = 25^{\circ}\text{C}, \ I_{F} = 10 \ \mu\text{A}$ $T_{j} = 25^{\circ}\text{C}, \ I_{F} = 50 \ \mu\text{A}$ $T_{j} = 25^{\circ}\text{C}, \ I_{F} = 200 \ \mu\text{A}$ $T_{j} = 25^{\circ}\text{C}, \ I_{F} = 500 \ \mu\text{A}$
Sensor forward voltage temperature coefficient	TC	- - -	5.9644 5.5880 5.2287 5.0135	-	mV/K	$\begin{array}{l} 25^{\circ}C \leq T_{j} \leq 175^{\circ}C, \ I_{F} = 10 \ \mu A \\ 25^{\circ}C \leq T_{j} \leq 175^{\circ}C, \ I_{F} = 50 \ \mu A \\ 25^{\circ}C \leq T_{j} \leq 175^{\circ}C, \ I_{F} = 200 \ \mu A \\ 25^{\circ}C \leq T_{j} \leq 175^{\circ}C, \ I_{F} = 500 \ \mu A \end{array}$
Sensor forward voltage	V _{F_175}	-	0.7072 0.9721 1.1963 1.3445	-	V	$T_{j} = 175^{\circ}\text{C}, \ I_{F} = 10 \ \mu\text{A}$ $T_{j} = 175^{\circ}\text{C}, \ I_{F} = 50 \ \mu\text{A}$ $T_{j} = 175^{\circ}\text{C}, \ I_{F} = 200 \ \mu\text{A}$ $T_{j} = 175^{\circ}\text{C}, \ I_{F} = 500 \ \mu\text{A}$
Reverse leakage current	I _R	-	-	1 20	μA	V _R = 10V, T _j = 25°C V _R = 10V, T _j = 175°C
Sensor G Capacitance	C _{GTS}	-	4.2	-	pF	f = 1 MHz, I _F = 50 μA
Sensor Capacitance	C _{STS}	-	4.8	-	pF	f = 1 MHz, I _F = 50 μA
Anode-Drain Capacitance	C _{DTS}	-	0.5	-	pF	f = 1 MHz, V _{DS} = 0 V

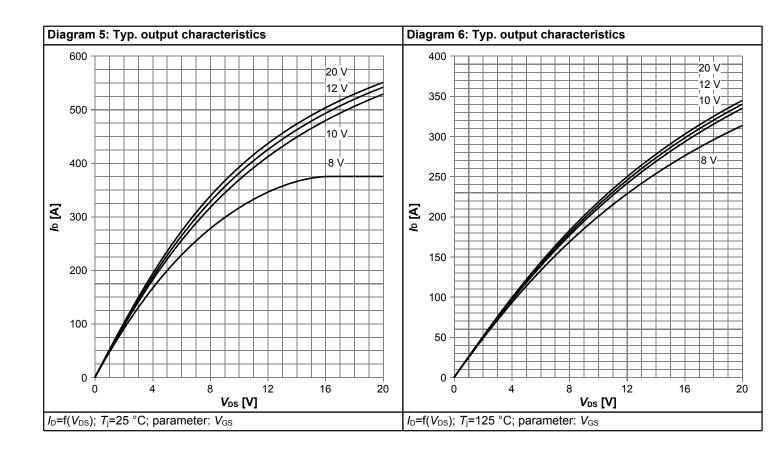


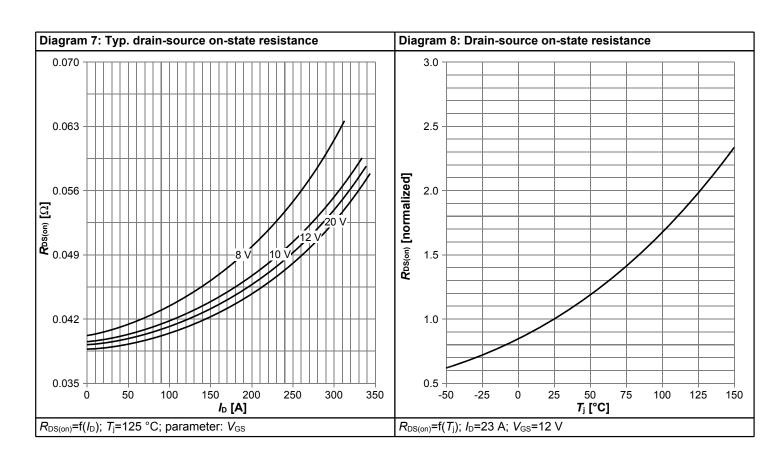
5 Electrical characteristics diagrams



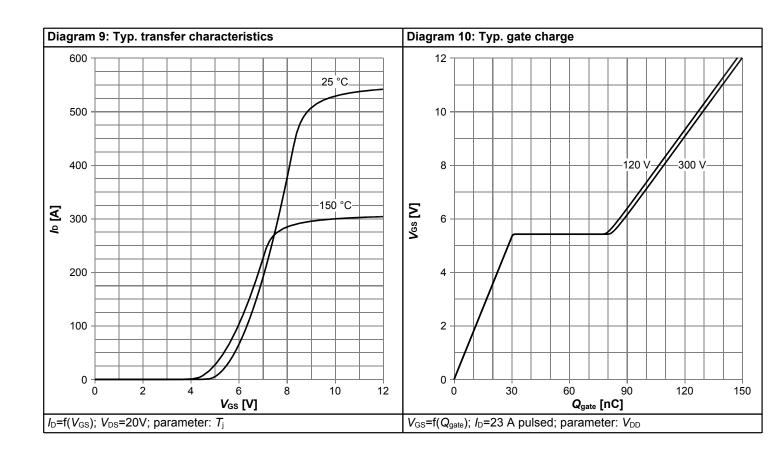


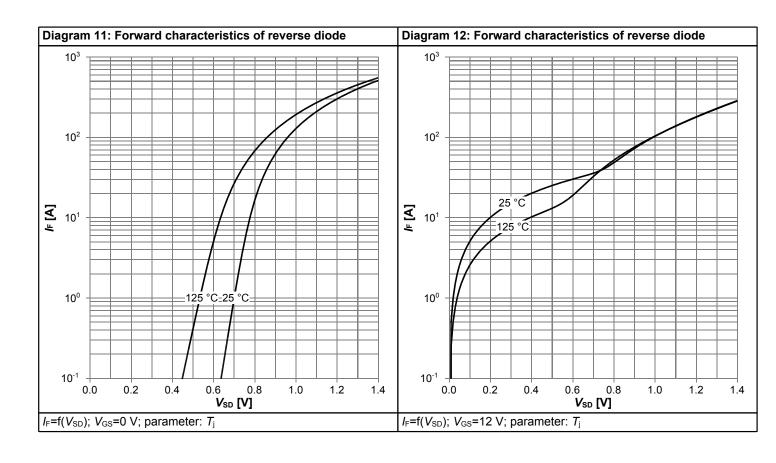




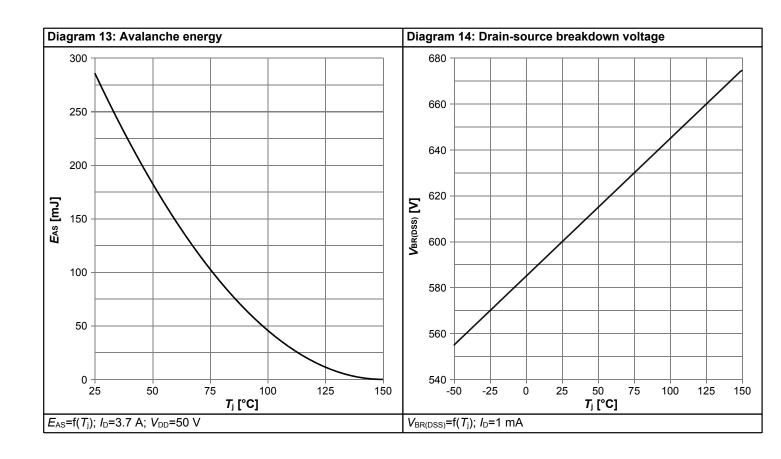


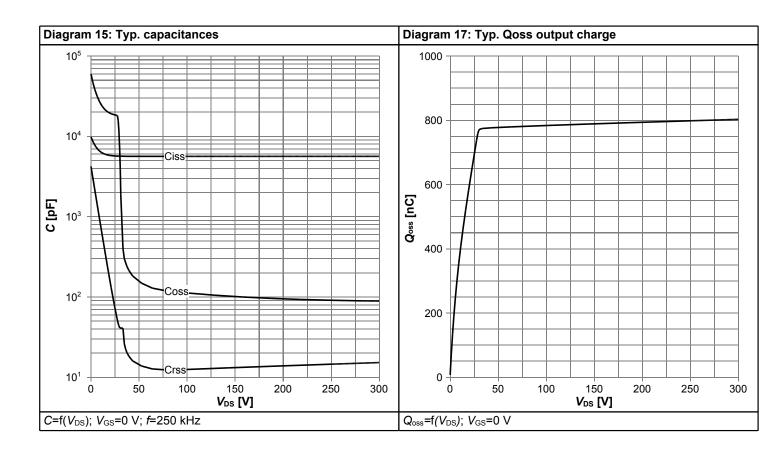




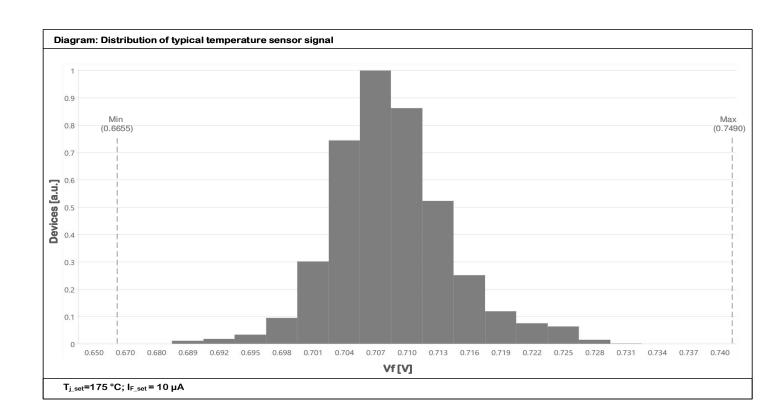














6 Test Circuits

Table 10 Diode characteristics

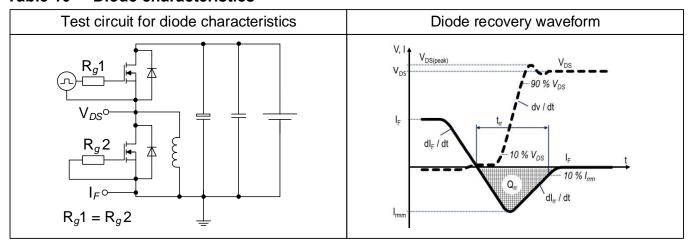


Table 11 Switching times (ss)

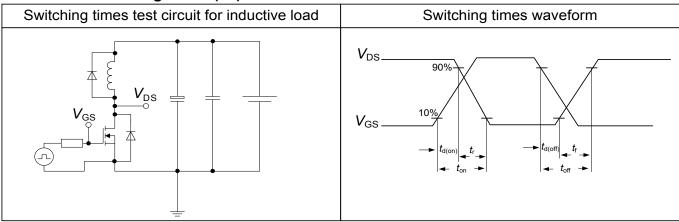
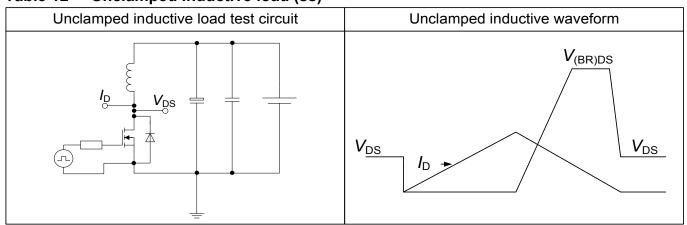


Table 12 Unclamped inductive load (ss)





7 Package Outlines

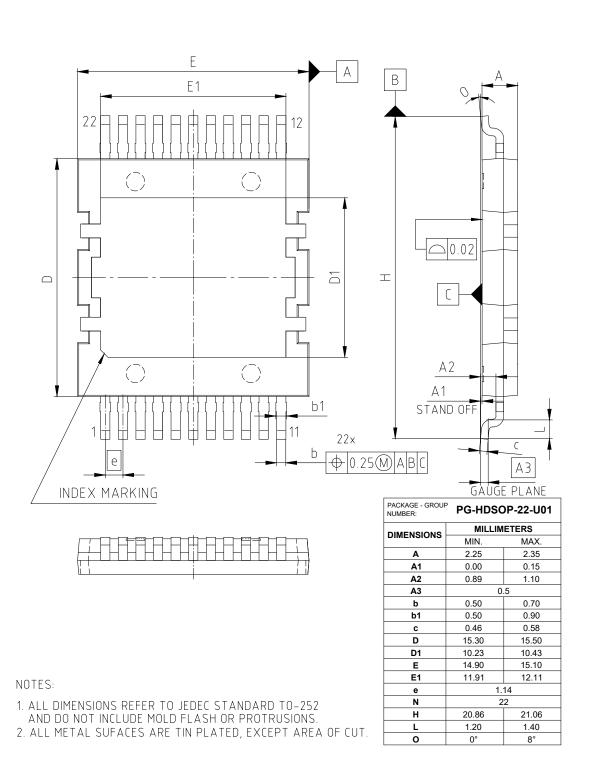


Figure 1 Outline PG-HDSOP-22, dimensions in mm

Final Data Sheet 14 Rev. 2.0, 2023-12-11

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8 Appendix A

Table 13 Related Links

• IFX CoolMOS S7T Webpage: www.infineon.com

• IFX CoolMOS S7T application note: www.infineon.com

• IFX CoolMOS S7T simulation model: www.infineon.com

• IFX Design tools: www.infineon.com

600V CoolMOS™ SJ S7 Power Device





Revision History

IPDQ60T022S7

Revision: 2023-12-11, Rev. 2.0

Previous Revision	Previous	Revision
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Revision	Date	Subjects (major changes since last revision)
2.0	2023-12-11	Release of final version

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